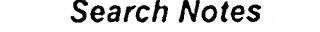


Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/787,079	SEKIGUCHI ET AL.
	Examiner	Art Unit
	Quang T. Van	3742

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219	619,211	10/12/05	SN
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